Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/709,088	TSAI, WEN-HSIEN	
Examiner	Art Unit	
Mark J. Beauchaine	3653	

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	SEARCHED				
Class	Subclass	Date	Examiner		
194	203,202, 344,353	12/1/2005	МЈВ		
232	7				
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
					
					

(INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST 2.0.2 - USPAT, USPGPUB, JPO, EPO, DERWENT	12/1/2005	МЈВ